

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination IKEDA ET AL.	
		Examiner Benny Q. Tieu	Art Unit 2614	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,792,245	09-2004	Kawai, Eiji	455/3.01
*	B	US-6,834,111	12-2004	Nishimura et al.	380/255
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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